

FMI16N60ES

FUJI POWER MOSFET

Super FAP-E^{3S} series

N-CHANNEL SILICON POWER MOSFET

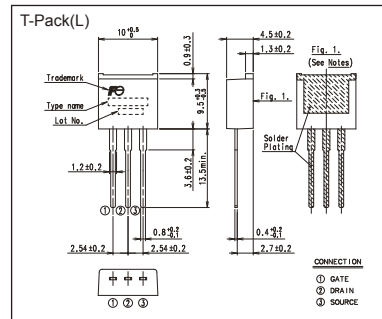
Features

- Maintains both low power loss and low noise
- Lower $R_{DS(on)}$ characteristic
- More controllable switching dv/dt by gate resistance
- Smaller V_{GS} ringing waveform during switching
- Narrow band of the gate threshold voltage ($4.2 \pm 0.5V$)
- High avalanche durability

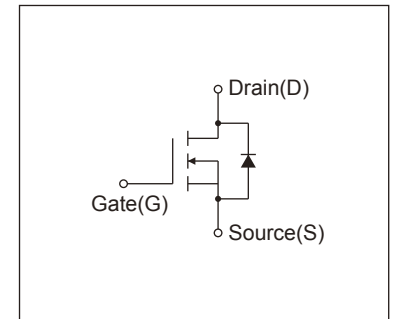
Applications

- Switching regulators
- UPS (Uninterruptible Power Supply)
- DC-DC converters

Outline Drawings [mm]



Equivalent circuit schematic



Maximum Ratings and Characteristics

Absolute Maximum Ratings at $T_c=25^\circ C$ (unless otherwise specified)

Description	Symbol	Characteristics	Unit	Remarks
Drain-Source Voltage	V_{DS}	600	V	
	V_{DSX}	600	V	$V_{GS} = -30V$
Continuous Drain Current	I_D	± 16	A	
Pulsed Drain Current	I_{DP}	± 64	A	
Gate-Source Voltage	V_{GS}	± 30	V	
Repetitive and Non-Repetitive Maximum Avalanche Current	I_{AR}	16	A	Note*1
Non-Repetitive Maximum Avalanche Energy	E_{AS}	554.8	mJ	Note*2
Repetitive Maximum Avalanche Energy	E_{AR}	27	mJ	Note*3
Peak Diode Recovery dV/dt	dV/dt	3.8	kV/ μs	Note*4
Peak Diode Recovery $-di/dt$	$-di/dt$	100	A/ μs	Note*5
Maximum Power Dissipation	P_D	2.16	W	$T_a=25^\circ C$
		270		$T_c=25^\circ C$
Operating and Storage Temperature range	T_{ch}	150	$^\circ C$	
	T_{stg}	-55 to + 150	$^\circ C$	

Electrical Characteristics at $T_c=25^\circ C$ (unless otherwise specified)

Description	Symbol	Conditions	min.	typ.	max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=250\mu A, V_{GS}=0V$	600	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$I_D=250\mu A, V_{DS}=V_{GS}$	3.7	4.2	4.7	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$	-	-	25	μA
		$V_{DS}=480V, V_{GS}=0V$	-	-	250	
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 30V, V_{DS}=0V$	-	10	100	nA
Drain-Source On-State Resistance	$R_{DS(on)}$	$I_D=8A, V_{GS}=10V$	-	0.40	0.47	Ω
Forward Transconductance	g_{fs}	$I_D=8A, V_{DS}=25V$	5	10	-	S
Input Capacitance	C_{iss}	$V_{DS}=25V$	-	2100	3150	pF
Output Capacitance	C_{oss}	$V_{GS}=0V$	-	230	345	
Reverse Transfer Capacitance	C_{rss}	$f=1MHz$	-	13	19.5	
Turn-On Time	$t_d(on)$	$V_{cc}=300V$	-	43	64.5	ns
	t_r	$V_{GS}=10V$	-	41	61.5	
Turn-Off Time	$t_d(off)$	$I_D=8A$	-	94	141	
	t_f	$R_G=18\Omega$	-	20	30	
Total Gate Charge	Q_G	$V_{cc}=300V$	-	56	114	nC
Gate-Source Charge	Q_{GS}	$I_D=16A$	-	20	25.5	
Gate-Drain Charge	Q_{GD}	$V_{GS}=10V$	-	21	33	
Gate-Drain Crossover Charge	Q_{SW}		-	9.5	10	
Avalanche Capability	I_{AV}	$L=1.74mH, T_{ch}=25^\circ C$	16	-	-	A
Diode Forward On-Voltage	V_{SD}	$I_F=16A, V_{GS}=0V, T_{ch}=25^\circ C$	-	0.90	1.35	V
Reverse Recovery Time	t_{rr}	$I_F=16A, V_{GS}=0V$	-	0.7	-	μs
Reverse Recovery Charge	Q_{rr}	$-di/dt=100A/\mu s, T_{ch}=25^\circ C$	-	9.0	-	μC

Thermal Characteristics

Description	Symbol	Test Conditions	min.	typ.	max.	Unit
Thermal resistance	$R_{th(ch-c)}$	Channel to case			0.460	$^\circ C/W$
	$R_{th(ch-a)}$	Channel to ambient			75.0	$^\circ C/W$

Note *1 : $T_{ch} \leq 150^\circ C$

Note *2 : Stating $T_{ch}=25^\circ C, I_{AS}=7A, L=20.8mH, V_{cc}=60V, R_G=50\Omega$
 E_{AS} limited by maximum channel temperature and avalanche current.
 See to 'Avalanche Energy' graph.

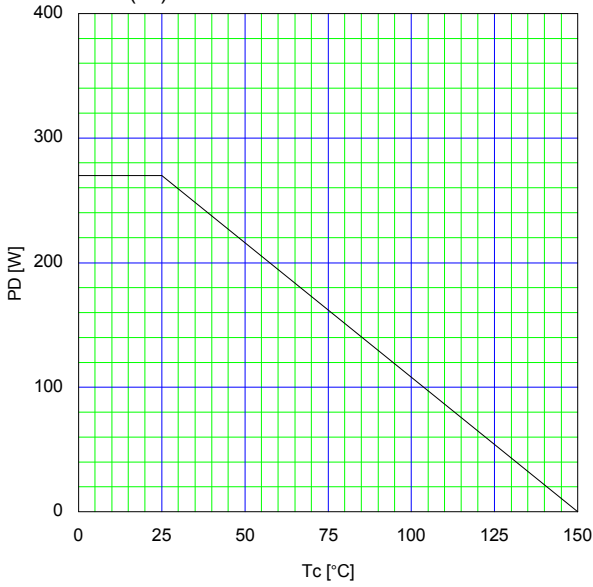
Note *3 : Repetitive rating : Pulse width limited by maximum channel temperature.

See to the 'Transient Thermal impedance' graph.

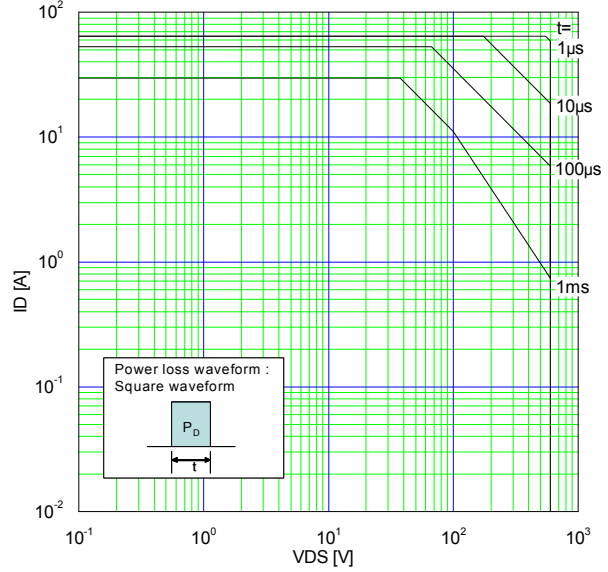
Note *4 : $I_F \leq I_D, -di/dt=100A/\mu s, V_{cc} \leq BV_{DSS}, T_{ch} \leq 150^\circ C$.

Note *5 : $I_F \leq I_D, dv/dt=3.8kV/\mu s, V_{cc} \leq BV_{DSS}, T_{ch} \leq 150^\circ C$.

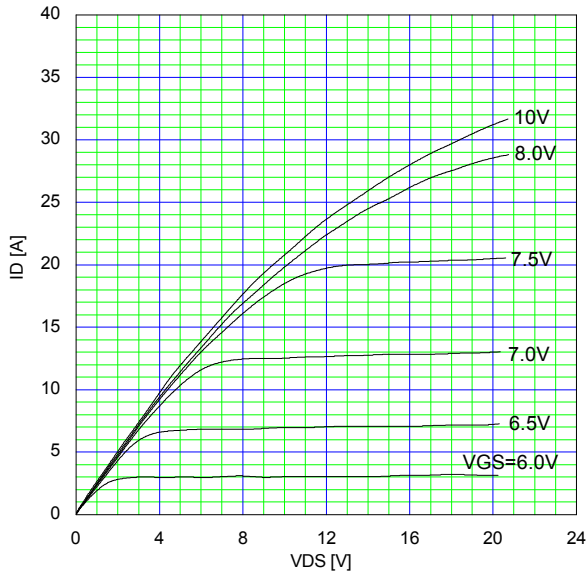
Allowable Power Dissipation
 $PD=f(T_c)$



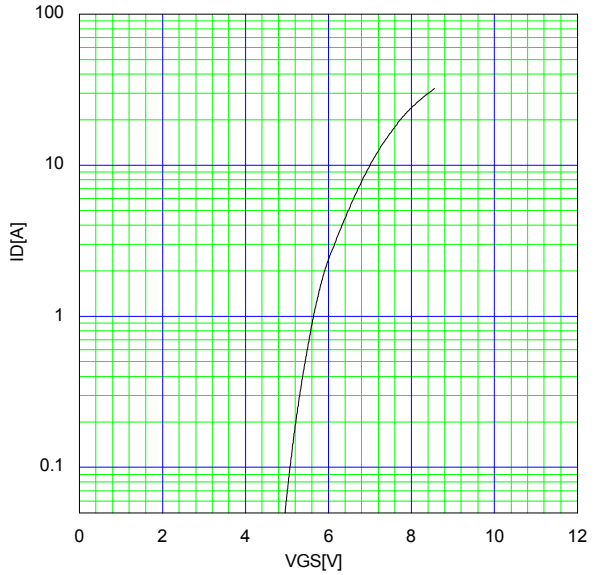
Safe Operating Area
 $I_D=f(V_{DS}): \text{Duty}=0(\text{Single pulse}), T_c=25^\circ\text{C}$



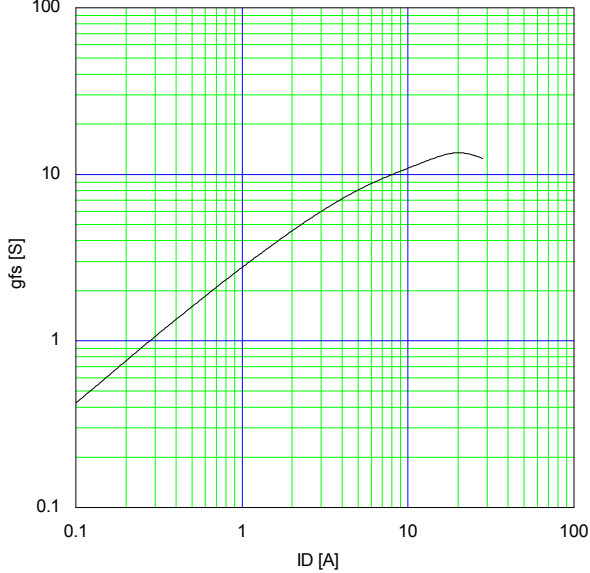
Typical Output Characteristics
 $I_D=f(V_{DS}): 80\ \mu\text{s}\ \text{pulse test}, T_{ch}=25^\circ\text{C}$



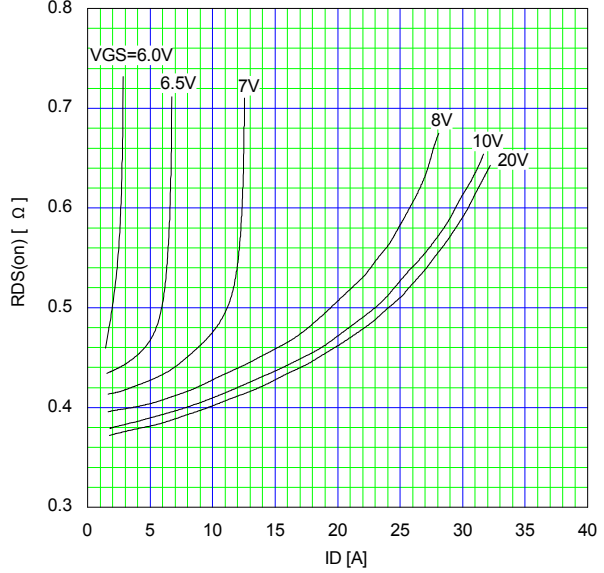
Typical Transfer Characteristic
 $I_D=f(V_{GS}): 80\ \mu\text{s}\ \text{pulse test}, V_{DS}=25\text{V}, T_{ch}=25^\circ\text{C}$



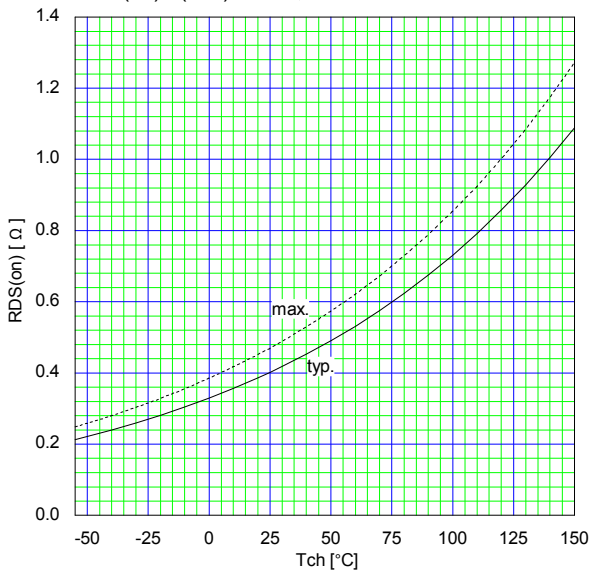
Typical Transconductance
 $g_{fs}=f(I_D): 80\ \mu\text{s}\ \text{pulse test}, V_{DS}=25\text{V}, T_{ch}=25^\circ\text{C}$



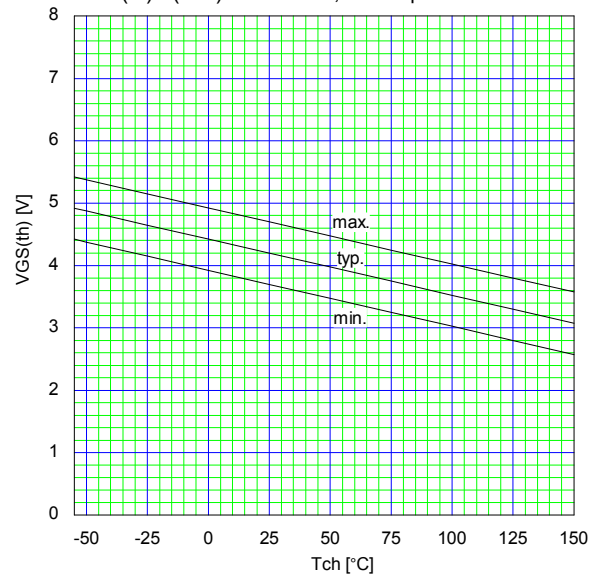
Typical Drain-Source on-state Resistance
 $R_{DS(on)}=f(I_D): 80\ \mu\text{s}\ \text{pulse test}, T_{ch}=25^\circ\text{C}$



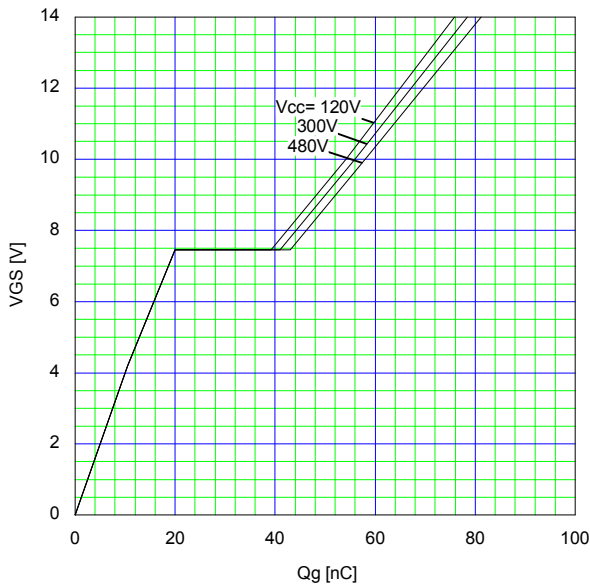
Drain-Source On-state Resistance
 $R_{DS(on)}=f(T_{ch}): I_D=8A, V_{GS}=10V$



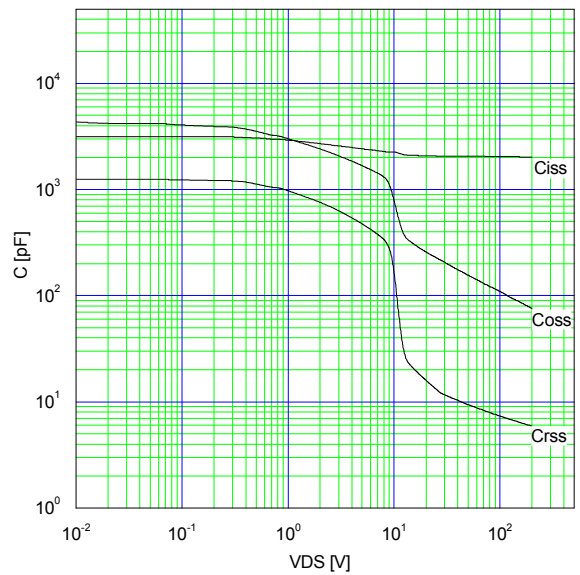
Gate Threshold Voltage vs. T_{ch}
 $V_{GS(th)}=f(T_{ch}): V_{DS}=V_{GS}, I_D=250\mu A$



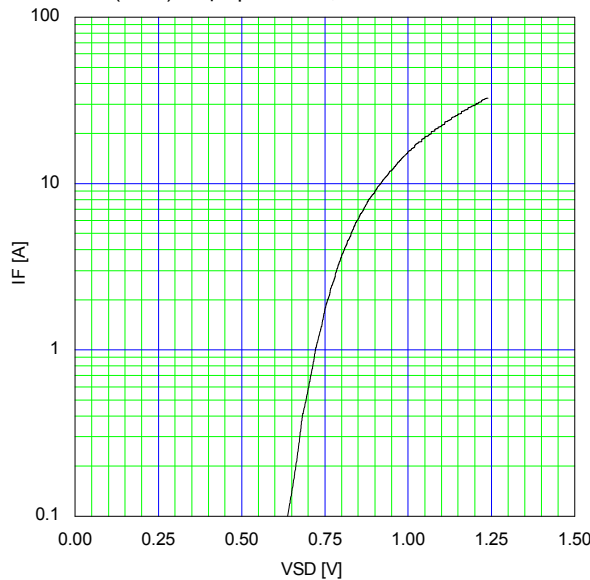
Typical Gate Charge Characteristics
 $V_{GS}=f(Q_g): I_D=16A, T_{ch}=25\text{ }^\circ\text{C}$



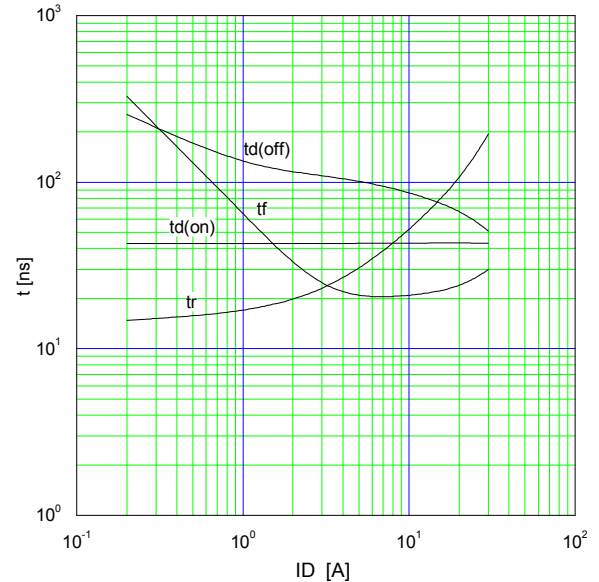
Typical Capacitance
 $C=f(V_{DS}): V_{GS}=0V, f=1\text{MHz}$



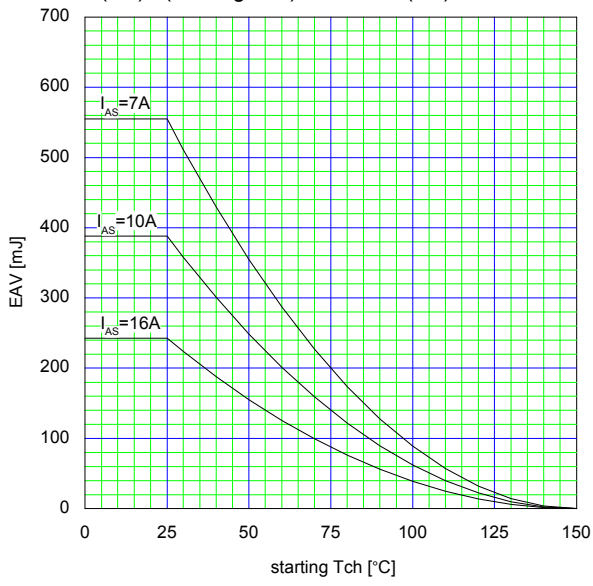
Typical Forward Characteristics of Reverse Diode
 $I_F=f(V_{SD}): 80\text{ }\mu\text{s pulse test}, T_{ch}=25\text{ }^\circ\text{C}$



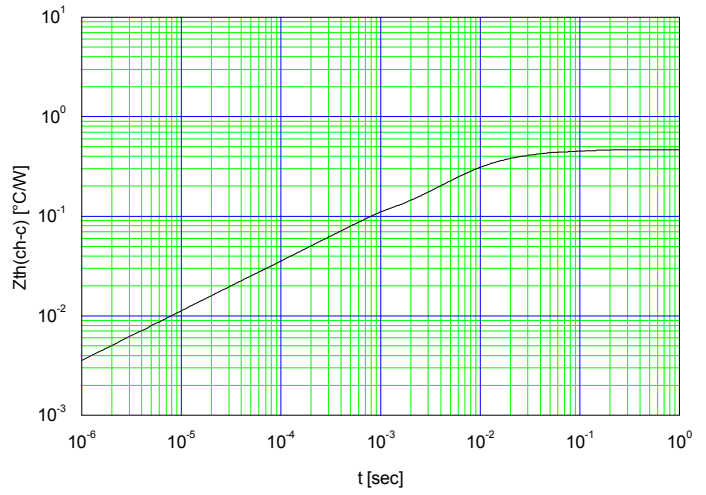
Typical Switching Characteristics vs. ID
 $t=f(I_D): V_{cc}=300V, V_{GS}=10V, R_G=18\text{ }\Omega$



Maximum Avalanche Energy vs. starting Tch
 $E(AV)=f(\text{starting Tch}):V_{CC}=60V, I(AV)\leq 16A$



Maximum Transient Thermal Impedance
 $Z_{th}(ch-c)=f(t):D=0$



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